Applicant(s): Application No. PROPER S LARRY S. EOFF ET AL. 10/825,001 Information Disclosure Citation in an Application Group Art Unit Filing Date **Docket Number** 2002-IP-007056U2 1712 04/15/04 MAR 0 2 2006 LS. PATENDOCUMENTS **SUBCLASS FILING DATE** CLASS DATE NAME DOCUMENT NO. 05/04/95 120 01/28/97 Audibert, et al. 307 5,597,763 120 05/04/95 507 06/10/97 | Argiller, et al. 5,637,556 01/11/90 166 294 5,720,347 02/24/98 | Audibert, et al. 4. GS 0.554 08/01/83 Z32 4,814,096 03/21/89 Evani US 2005/0230116 US Pat. App. Ser. 07/15/05 No. 11/183,028) Nguyen, et al. **FOREIGN PATENT DOCUMENTS** TRANSLATION SUBCLASS CLASS DATE COUNTRY DOCUMENT NO. YES NO GS E21 B 41/26 X 11/4/04 PCT WO 2004/094781 X E2BB 43/26 07/10/03 PCT WO 2003/056130 GS GS COBK 7/02 Х WO 2000/78890 12/28/00 PCT NON-PATENT DOCUMENTS . DATE **DOCUMENT (Including Author, Title, Source, and Pertinent Pages)** XU, ET AL., MODELING OF LASER SPALLATION DRILLING OF ROCKS FOR GAS-AND OILWELL DRILLING, SPE 95746, 2005 GS GAHAN, ET AL., EFFECT OF DOWNHOLE PRESSURE CONDITIONS ON HIGH-POWER LASER PERFORATION, SPE 97093, 2005 GAHAN, ET AL., ANALYSIS OF EFFICIENT HIGH-POWER FIBER LASERS OF WELL PERFORATION, SPE 90661, 2004 PARKER, ET AL., WELL PERFORATION USING HIGH-POWER LASERS, SPE 84418, 2003 PARKER, ET AL., LASER DRILLING: EFFECTS OF BEAM APPLICATION METHODS ON IMPROVING ROCK REMOVAL, SPE 84353, 2003 BAI, ET AL., IMPROVED DETERMINATION OF STREE-DEPENDENT PERMEABILITY FOR ANISOTROPIC FORMATIONS, SPE 78188, 2002 PROETT, ET AL., ADVANCED PERMEABILITY AND ANISOTROPY MEASUREMENTS WHILE TESTING AND SAMPLING IN REAL-TIME USING A DUAL PROBE FORMATION TESTER, SPE 62919, 2000 PROETT, ET AL., ADVANCED DUAL PROBE FORMATION TESTER WITH TRANSIENT, HARMONIC, AND PULSED TIME-DELAY TESTING METHODS DETERMINES PERMEABILITY, SKIN AND ANISOTROPY, SPE GS 64650, 2000 **EXAMINER** DATE CONSIDERED 06/22/2006 /George Suchfield/ EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through

citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

PTO-1449 **Information Disclosure Citation**

Application No. 10/825,011

Applicant(s):

LARRY S. EOFF ET AL.

Docket Number 2002-IP-007056U2 **Group Art Unit** 3676

Filing Date 04/15/2004

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